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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
<i>ISL</i>	2610780	12-08-1988	FR				NO
<i>ISL</i>	0530038	03-03-1993	EP				NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>ISL</i>		CHUNG YEON-CHOON ET AL., "Broadband Electromagnetic Absorber With Ferrite/Ferrite Hybrid Structure", Electronics Letters, IEEE Stevnage, GB, vol. 35, no. 18; Sep. 2, 1999, pp. 1526-1527, XP006012654.
<i>ISL</i>		SHIMADA, K., ET AL., "Fully Compact Anechoic Chamber Using the Pyramidal Ferrite Absorber For Immunity Test," 2000 IEEE International Symposium on Electromagnetic Compatibility." EMC. Symposium Record, Washington, DC, Aug. 21-25, 2000; International Symposium on Electromagnetic Compatibility, New York, NY: IEEE, US, vol. 1 of 2, Aug. 21, 2000, pp. 225-230, XP001077062
<i>ISL</i>		HAALA, J. ET AL., "Analysis and Optimization of Anechoic Chambers Equipped with Ferrite and Hybrid Absorbers Using FIT-FD," International Conference on Antennas and Propagation, London, GB, vol. 436, Part 1, Apr. 14, 1997, pp. 1130-1135, XP001077051, Fig. 5
<i>ISL</i>		ISHINKO, K. ET AL., "Realization of Compact Semi- and Fully Anechoic Chambers Using A New Developed Composite Absorber," Electromagnetic Compatibility, Nov. 1994. Symposium Record. Compatibility in the Loop., IEEE International Symposium in Chicago, IL, Aug. 22-26, 1994, New York, NY, IEEE, Aug. 22, 1994, pp. 413-418, XP010133044, Figure 1.

EXAMINER IAN J. LOBO	DATE CONSIDERED 8/21/02.
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